

Notice of References Cited			Application/Control No.	Applicant(s)/Patent Under Reexamination	
			10/811,850	HA, CHANG JIN	
			Examiner	Art Unit	Page 1 of 1
			Robert W. Horn	2837	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2006/0181232 A1	08-2006	Olijaca et al.	318/268
*	B	US-2006/0013571 A1	01-2006	Squibb, George Farris	388/804
*	C	US-2005/0040779 A1	02-2005	Frankel et al.	318/268
*	D	US-2004/0263105 A1	12-2004	Tsai et al.	318/471
*	E	US-2004/0257013 A1	12-2004	Chhleda et al.	318/268
*	F	US-2003/0201741 A1	10-2003	Lee, Hung-Pin	318/268
*	G	US-2003/0137267 A1	07-2003	Blake, John	318/471
*	H	US-2002/0140389 A1	10-2002	Ohki et al.	318/471
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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